Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
10/640,851	BECHTEL ET AL.
Examiner	Art Unit
Thanh X Luu	2878

			
SEARCHED			
Class	Subclass	Date	Examiner
250	205, 208.1, 214AL, 239	oylos	WL
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INTERFERENCE SEARCHED				
Class	Subclass	Date		Examiner
Same as	above	04/0	15	JXC
-		10-		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
		